

<b>Notice of References Cited</b>	Application/Control No. 10/068,004	Applicant(s)/Patent Under Reexamination SO ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,837,568	11-1998	Yoneda et al.	438/147
	B	US-2003/0207502	11-2003	Yamazaki et al.	438/149
	C	US-5,568,288	10-1996	Yamazaki et al.	349/42
	D	US-5,897,344	04-1999	Teramoto et al.	438/149
	E	US-6,706,569	03-2004	Kim et al.	438/149
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-261076	09-1999	Japan	Yamazaki et al	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.